

Search Notes

Application/Control No.

10/042,082

Examiner

Tse Chen

Applicant(s)/Patent under
Reexamination

ABERNATHY ET AL.

Art Unit

2116

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
total srch only - see srch rpt prt out	9/27/05	TSE